# HLF 

## FEATURES

- Efficiency
- Input voltage range
- Withstanding input voltage surge
- Output current range
- String of LEDs
- Constant-current LED driver
- Linear and PWM dimming capability


## APPLICATIONS

- DC/DC or AC/DC LED driver
- RGB backlighting LED driver
- Backlighting of flat panel displays
- General-purpose constant current source
- Signage and decorative LED lighting
- Automotive
- Chargers
>90\%
- Chargers


10 V to 600 V
up to 600V
a few mA to more than 1A
1 pc to several hundreds

## DESCRIPTION

The 9910 is a PWM high-efficiency LED driver control IC. It allows efficient operation of highbrightness (HB) LEDs from 10VDC up to 600VDC voltage sources. The circuit controls an external MOSFET at fixed switching frequencies up to 300 kHz . The frequency can be programmed by using a single resistor. The device peculiarity is that a LED string is driven at a constant current rather than at a constant voltage, thus providing a constant light output and an enhanced reliability. The output current can be programmed between a few milliamps and up to more than 1.0A. A rugged high-voltage junction isolated process was used and enabled the device to withstand an input voltage surge up to 600V. The output current to a LED string is programmable to any value between zero and its maximum value by applying an external control voltage to the linear dimming control input. To allow the device to accept an external control signal with a duty ratio of 0 to $100 \%$ and a frequency of up to a few kilohertz the circuit has a low-frequency PWM dimming input.

## TYPICAL APPLICATION CIRCUIT



## ABSOLUTE MAXIMUM RATINGS

Vin to GND
-0.5 V to +600 V
CS, LD, PWM_D, GATE to GND
Continuous power dissipation ( $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$ ) (Note 1) 8 -pin DIP (derate $9 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ above $+25^{\circ} \mathrm{C}$ )
8 -pin SO-8 (derate $6.3 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ above $+25^{\circ} \mathrm{C}$ )
Operating temperature range
Junction temperature
-0.3 V to $\mathrm{V}_{\mathrm{DD}}+0.3 \mathrm{~V}$

Storage temperature range
900 mW
630 mW
$-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$
$+125^{\circ} \mathrm{C}$

Stresses beyond those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS
( $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$ unless noted otherwise)

| SYMBOL | DESCRIPTION | MIN | TYP | MAX | UNITS | CONDITIONS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {INDC }}{ }^{1}$ | Input DC supply voltage range | 10.0 |  | 600 | V | DC input voltage |
| IINSD | Shut-down mode supply current | 0.5 |  | 1 | mA | Pin PWM_D to GND, $\mathrm{V}_{\text {IN }}=8 \mathrm{~V}$ |
| $V_{D D}$ | Internally regulated voltage | 7.0 | 7.5 | 8.0 | V | $\mathrm{V}_{\mathrm{IN}}=10 \mathrm{~V} \text { to } 600 \mathrm{~V}, \mathrm{I}_{\mathrm{DD}(\text { ext })}=0,$ pin GATE is open |
| $\Delta V_{\text {DD }}$, load | $V_{\text {DD }}$ load regulation | 0 | - | 100 | mV | $\mathrm{I}_{\mathrm{DD}(\text { ext })}=0$ to $1.0 \mathrm{~mA}, 500 \mathrm{pF}$ at GATE; Rosc $=226 \mathrm{kOhm}$, PWM_D = VDD |
| $\mathrm{V}_{\mathrm{DD} \text {, max }}$ | Maximal pin $\mathrm{V}_{\mathrm{DD}}$ voltage |  |  | 10.0 | V | When an external voltage is applied to pin $\mathrm{V}_{\mathrm{DD}}$ |
| $\mathrm{I}_{\text {DD(ext) }}$ | $\mathrm{V}_{\text {DD }}$ current available for external circuitry |  |  | 0.7 | mA | $\mathrm{V}_{\mathrm{IN}}=10 \mathrm{~V}$ to 100 V |
| UVLO | $\mathrm{V}_{\mathrm{DD}}$ undervoltage lockout threshold | $0.87 * V_{\text {DD }}$ | $0.89 * V_{\text {DD }}$ | $0.91{ }^{*} \mathrm{~V}_{\mathrm{DD}}$ | \% | Rising $\mathrm{V}_{\text {IN }}$ |
| $\Delta \mathrm{UVLO}$ | $V_{D D}$ undervoltage lockout hysteresis |  | 500 |  | mV | Falling $\mathrm{V}_{\mathrm{IN}}$ |
| $\mathrm{V}_{\mathrm{EN}(10)}$ | Pin PWM_D input low voltage |  |  | 0.8 | V | $\mathrm{V}_{\mathrm{IN}}=10 \mathrm{~V}$ to 600 V |
| $\mathrm{V}_{\text {EN(hi) }}$ | Pin PWM_D input high voltage | 2.0 |  |  | V | $\mathrm{V}_{\text {IN }}=10 \mathrm{~V}$ to 600 V |
| $\mathrm{R}_{\text {EN }}$ | Pin PWM_D pull-down resistance | 50 | 100 | 150 | kOhm | $\mathrm{V}_{\mathrm{EN}}=5 \mathrm{~V}$ |
| $\mathrm{dV}_{\text {cs }}$ | Accuracy of Current Sense threshold voltage at wafer testing | -2.4\% | 0 | 2.4\% | \% |  |
| $\mathrm{V}_{\text {CS(hi) }}$ | Current sense pull-in threshold voltage | 238 | 250 | 262 | mV | $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |
| $\mathrm{V}_{\text {GATE(hi) }}$ | GATE high output voltage | $\mathrm{V}_{\mathrm{DD}}-0.3$ |  | $V_{D D}$ | V | l OUt $=10 \mathrm{~mA}$ |
| $\mathrm{V}_{\text {GATE( }}$ (0) | GATE low output voltage | 0 |  | 0.3 | V | $\mathrm{I}_{\text {OUT }}=-10 \mathrm{~mA}$ |
| fosc | Oscillator frequency | $\begin{aligned} & 20 \\ & 80 \end{aligned}$ | $\begin{gathered} 25 \\ 100 \end{gathered}$ | $\begin{gathered} 30 \\ 120 \end{gathered}$ | kHz | $\begin{aligned} & \text { Rosc }=1.00 \mathrm{MOhm} \\ & \text { Rosc }=226 \mathrm{kOhm} \end{aligned}$ |
| Dmax hf | Maximum oscillator PWM duty cycle |  |  | 100\% |  | $\mathrm{F}_{\text {Pwm }}$ hf $=25 \mathrm{kHz}$, at GATE, CS to GND |
| VLD | Pin LD (linear dimming) voltage range | 0 |  | 250 | mV | $\mathrm{T}_{\mathrm{A}}=<85^{\circ} \mathrm{C}, \mathrm{V}_{\text {IN }}=12 \mathrm{~V}$ |
| Tblank | Current sense blanking interval | 150 | 215 | 280 | ns | $\mathrm{V}_{\mathrm{CS}}=0.55 \mathrm{~V}_{\text {LD }}, \mathrm{V}_{\text {LD }}=\mathrm{V}_{\mathrm{DD}}$ |
| $t_{\text {DeLA }}$ | Delay from CS to GATE lo |  |  | 300 | ns | $\begin{aligned} & \mathrm{V}_{\mathrm{IN}}=12 \mathrm{~V}, \mathrm{~V}_{\mathrm{LD}}=0.15, \mathrm{~V}_{\mathrm{CS}}=0 \\ & \text { to } \\ & 0.22 \mathrm{~V} \text { after } \mathrm{T}_{\text {BLANK }} \end{aligned}$ |
| $\mathrm{t}_{\text {RISE }}$ | GATE output rise time | 30 |  | 50 | ns | $\mathrm{C}_{\text {GATE }}=500 \mathrm{pF}, \mathrm{V}_{\mathrm{DD}}=7.5 \mathrm{~V}$ |
| $\mathrm{t}_{\text {FALL }}$ | GATE output fall time | 30 |  | 50 | ns | $\mathrm{C}_{\text {GATE }}=500 \mathrm{pF}, \mathrm{V}_{\text {DD }}=7.5 \mathrm{~V}$ |

Note:

1. Also limited by package power dissipation limit, whichever is lower.

## HLF

## BLOCK DIAGRAM



## Application Note

## Oscillator

The oscillator in the 9910 is controlled by a single resistor connected at the RT pin. The equation governing the oscillator time period $\mathrm{t}_{\mathrm{osc}}$ is given by:

$$
\mathrm{t}_{\mathrm{osc}}(\mu \mathrm{~s})=\frac{\mathrm{R}_{\mathrm{T}}(\mathrm{k} \Omega)+22}{25}
$$

If the resistor is connected between RT and GND, 9910 operates in a constant frequency mode and the above equation determines the time-period. If the resistor is connected between RT and GATE, the 9910 operates in a constant off-time mode and the above equation determines the offtime.

## Current Sense Resistor

The formula for calculation of Iled for 9910 in typical application circuit is:

$$
\mathrm{R}_{\mathrm{CS}}=\frac{0.25 \mathrm{~V}\left(\mathrm{or} \mathrm{~V}_{\mathrm{LD}}\right)}{1.15 \cdot \mathrm{I}_{\mathrm{LED}}(\mathrm{~A})}
$$

## 9910PAD LOCATION



Chip size: $1.35 \mathrm{~mm} \times 1.50 \mathrm{~mm}$

| Pad Name | Pad Centre |  | Pad Size (Passivation) |  |
| :---: | :---: | :---: | :---: | :---: |
|  | $\mathbf{X}$ | $\mathbf{Y}$ | $\mathbf{X}$ | $\mathbf{Y}$ |
| Vin | 280 | 1210 |  |  |
| CS | 115 | 870 | 92 | 92 |
| GND | 145 | 696 | 92 | 92 |
| GATE | 145 | 545 | 92 | 92 |
| PWM_D | 145 | 392 | 92 | 92 |
| VDD | 632 | 116 | 92 | 92 |
| LD | 808 | 142 | 92 | 92 |
| Rosc | 1185 | 160 | 92 | 92 |

## 9910 BONDING DIAGRAM DIP-8 Package

(Bottom view)


The appearance complies with the requirements of the company standards.

